



N-channel 600 V, 0.85 Ω typ., 7 A Zener-protected SuperFREDMESH™ Power MOSFET (with fast diode) in D²PAK

Datasheet - production data

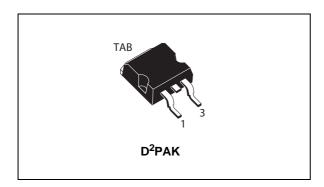
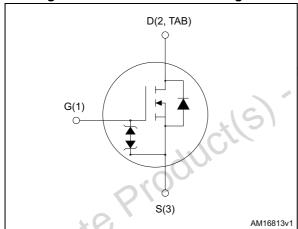


Figure 1. Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on) max} .	I _D	P _{TOT}
STB9NK60ZDT4	600 V	0.95 Ω	7 A	125 W

- Extremely high dv/dt capability
- Zener-protected
- 100% avalanche tested
- Gate charge minimized
- Low intrinsic capacitances
- Fast internal recovery diode

Applications

- Switching applications
- Fast internal recovery diode

Description

The device is developed using the revolutionary SuperFREDMeshTM technology. It associates all advantages of reduced on-resistance, Zener gate protection and very high dv/dt capability with a fast body-drain recovery diode. Such series complements the "FDmeshTM" advanced technology.

Table 1. Device summary

Order code	Marking	Package	Packaging
STB9NK60ZDT4	B9NK60ZD	D ² PAK	Tape and reel

Contents STB9NK60ZD

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STB9NK60ZD **Electrical ratings**

Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	600	V
V _{GS}	Gate-source voltage	±30	V
I _D	Drain current (continuous) at T _C = 25 °C	7	Α
I _D	Drain current (continuous) at T _C = 100 °C	4.3	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	28	Α
D.	Total dissipation at T _C = 25 °C	125	W
P _{TOT}	Derating factor	1 G	W/°C
V _{ESD(G-S)}	Gate-source ESD (HBM-C=100 pF, R=1.5 $k\Omega$)	4000	V
dv/dt (2)	Peak diode recovery voltage slope	15	V/ns
T _j	Max. operating junction temperature	- 55 to 150	°C
T _{stg}	Storage temperature	- 33 10 130	

^{1.} Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max.	1	°C/W
R _{thj-pcb}	Thermal resistance junction-pcb max. (1)	30	°C/W

^{1.} When mounted on 1 inch² FR-4, 2 Oz copper board.

Table 4. Avalanche characteristics

	1. When mounted	d on 1 inch² FR-4, 2 Oz copper board.		
10	10	Table 4. Avalanche characteristics		
cOlle	Symbol	Parameter	Value	Unit
Ops	I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	7	А
	E _{AS}	Single pulse avalanche energy (starting T_j =25 °C, I_D = I_{AR} ; V_{DD} = 50)	235	mJ

^{2.} $I_{SD} \le 7$ A, di/dt ≤ 500 A/µs; $V_{DD} = 80\%$ $V_{(BR)DSS}$

Electrical characteristics STB9NK60ZD

2 **Electrical characteristics**

(T_C = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			V
I _{DSS}		V _{DS} = 600 V V _{DS} = 600 V, T _C = 125 °C			1 50	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	2.5	3.5	4.5	V
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$	240	0.85	0.95	Ω

Table 6. Dynamic

	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 3.5 \text{ A}$	-	5.3		S
	C _{iss}	Input capacitance		-	1110		pF
	C _{oss}	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$	-	135		pF
	C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	30		pF
	Coss eq. (2)	Equivalent output capacitance	V _{DS} = 0 to 480 V, V _{GS} = 0	-	72		pF
7/6	Q_g	Total gate charge	V 400 V I 44 A	-	41	53	nC
,,,,	Q _{gs}	Gate-source charge	V _{DD} = 480 V, I _D = 11 A, V _{GS} = 10 V (see <i>Figure 15</i>)	-	8.7		nC
U.O.	Q_{gd}	Gate-drain charge	163 11 (1101 1907 107)	-	21		nC
	1. Pulsed: p	ulse duration= 300 μs, duty	cycle 1.5%.				

^{1.} Pulsed: pulse duration= 300 μ s, duty cycle 1.5%.

 $C_{oss\;eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% $V_{DSS}.$

 $t_{\rm c}$

20

ns

Symbol Parameter Test conditions Min. Тур. Max. Unit Turn-on delay time 11.4 ns t_{d(on)} $V_{DD} = 300 \text{ V}, I_D = 3.5 \text{ A},$ 13.6 t_{r} Rise time ns $R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Turn-off delay time 23.1 ns t_{d(off)} Figure 14 and Figure 19) Fall time 15 ns t_f Off-voltage rise time 11 ns t_{r(Voff)} $V_{DD} = 480 \text{ V}, I_D = 7 \text{ A},$ $R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see *Figure 14* and *Figure 19*) Fall time 8 t_f ns

Table 7. Switching times

Table 8. Source - drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		7	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)	10/6	-		28	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 7 \text{ A}, V_{GS} = 0$	-		1.6	V
t _{rr}	Reverse recovery time	10 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	-	130		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 7 A, di/dt = 100 A/μs V _{DD} = 30 V (see <i>Figure 16</i>)	-	550		nC
I _{RRM}	Reverse recovery current	L. DD GG T (GGG T IGGI G T G)	-	8.4		Α
t _{rr}	Reverse recovery time	I _{SD} = 7 A, di/dt = 100 A/μs	-	176		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 30 \text{ V}, T_j = 150 \text{ °C (see}$	-	880		nC
I _{RRM}	Reverse recovery current	Figure 16)	-	10		Α

1. Pulse width limited by safe operating area.

Cross-overtime

Table 9. Gate - source Zener diode

		duration= 300 μs, duty cycle					
c0'		Table 9. 0	Gate - source Zene	er diode			
0/02	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	BV _{GSO} ⁽¹⁾	Gate-source breakdown voltage	Igs= ± 1 mA (open drain)	30			V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

Electrical characteristics STB9NK60ZD

Electrical characteristics (curves) 2.1

Figure 2. Safe operating area

Figure 3. Thermal impedance

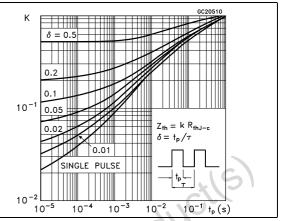


Figure 4. Output characteristics

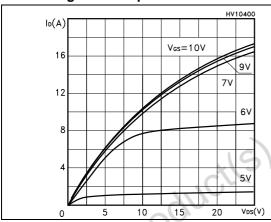


Figure 5. Transfer characteristics

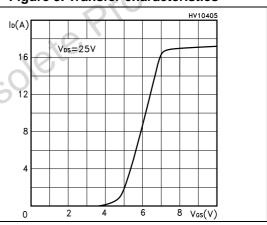


Figure 6. Normalized BVDSS vs temperature

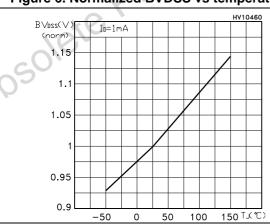


Figure 7. Static drain-source on-resistance

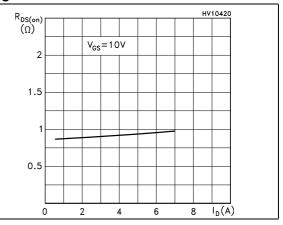


Figure 8. Gate charge vs gate-source voltage

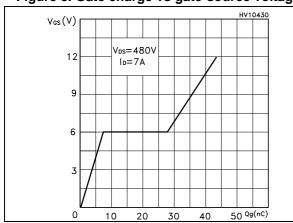


Figure 9. Capacitance variations

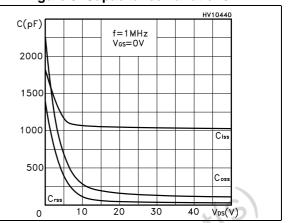
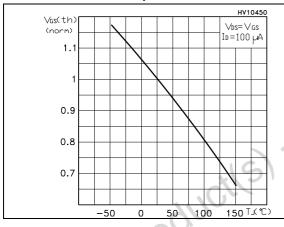


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



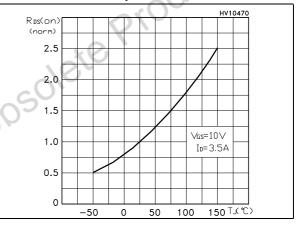
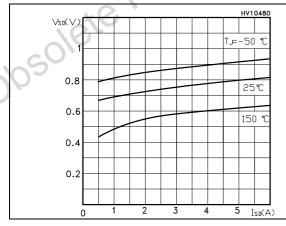
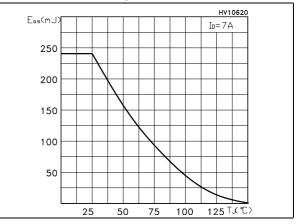


Figure 12. Source-drain diode forward characteristics

Figure 13. Maximum avalanche energy vs temperature





Test circuits STB9NK60ZD

3 Test circuits

Figure 14. Switching time test circuit for resistive load

Figure 15. Gate charge test circuit

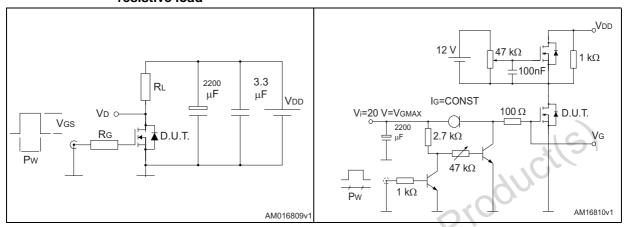


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

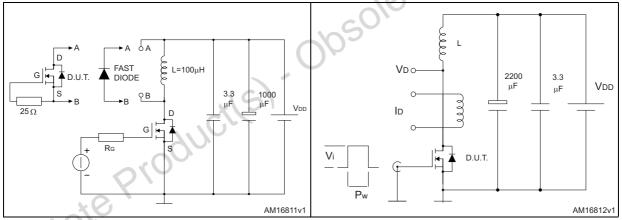
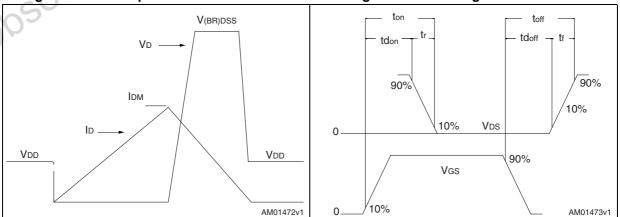


Figure 18. Unclamped inductive waveform

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Figure 19. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

Table 10. D²PAK (TO-263) mechanical data

	B:		mm	
	Dim.	Min.	Тур.	Max.
	А	4.40		4.60
	A1	0.03		0.23
	b	0.70		0.93
	b2	1.14		1.70
	С	0.45		0.60
	c2	1.23	1010	1.36
	D	8.95		9.35
	D1	7.50	W2	
	E	10		10.40
	E1	8.50		
	е	.(5)	2.54	
	e1	4.88		5.28
	Н	15		15.85
	J1, (C	2.49		2.69
	L	2.29		2.79
\ C	L1	1.27		1.40
Olk	L2	1.30		1.75
1050le	R		0.4	
)~	V2	0°		8°

THERMAL PAD

SEATING PLANE

COPLANARITY A1

R

Q25

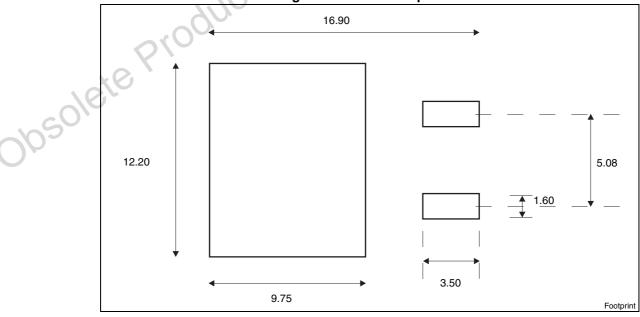
GAUGE PLANE

V2

0079457_T

Figure 20. D²PAK (TO-263) drawing





a. All dimensions are in millimeters.

5 Packaging mechanical data

Table 11. D²PAK (TO-263) tape and reel mechanical data

	Таре			Reel		
Di	mm		Dim	mm		
Dim	Min.	Max.	Dim.	Min.	Max.	
A0	10.5	10.7	А		330	
В0	15.7	15.9	В	1.5		
D	1.5	1.6	С	12.8	13.2	
D1	1.59	1.61	D	20.2	. (C)	
Е	1.65	1.85	G	24.4	26.4	
F	11.4	11.6	N	100		
K0	4.8	5.0	Т		30.4	
P0	3.9	4.1	10	10		
P1	11.9	12.1	0//	Base qty	1000	
P2	1.9	2.1	5	Bulk qty	1000	
R	50	0,				
Т	0.25	0.35				
W	23.7	9 24.3				
ite (23.7					

10 pitches cumulative tolerance on tape +/- 0.2 mm
Top cover tape

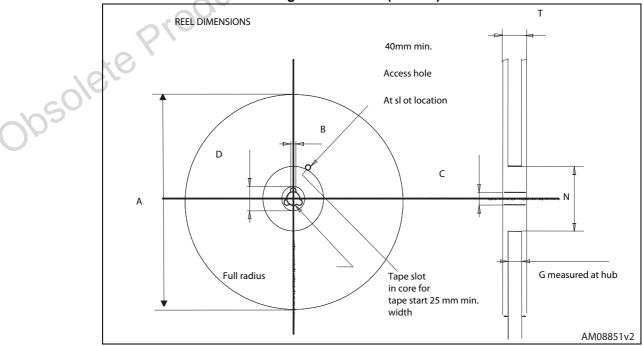
User direction of feed

User direction of feed

AM08852v2

Figure 22. D²PAK (TO-263) tape





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STB9NK60ZD Revision history

6 Revision history

Table 12. Document revision history

	Date	Revision	Changes
	29-Sep-2003	6	Data updated.
	13-Jun-2006	7	The doc. has been reformatted.
	14-Apr-2008	8	Table 8 has been corrected. Package mechanical data updated.
	11-Jul-2013	9	-The part numbers: STF9NK60ZD and STP9NK60ZD have been moved to a separate datasheetChanged the title and <i>Figure 1</i> Added Zener-protected to the featuresMinor text changes.
Obsolete Product(s). Obsolete Product(s).			

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